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| Form PTO-1449   |  | ATTORNEY DOCKET NO. | SERIAL NO.            |
| PATENT AND TRADEMARK OFFICE<br>INFORMATION DISCLOSURE CITIGATION<br>(Use several sheets if necessary) |  | 11-173              | 10/626,721            |
| Sheet 1 of 1  |  | APPLICANT           | Hiroyuki TSUJI et al. |
|   |  | FILING DATE         | GROUP                 |
|   |  | 7/25/03             | 2636                  |

| U.S.PATENT DOCUMENTS |                        |                    |         |  |                    |                                 |
|----------------------|------------------------|--------------------|---------|--|--------------------|---------------------------------|
| Ref.<br>Desig.       | Examiner's<br>Initials | Document<br>Number | Date    | Name                                   | Class/<br>Subclass | (If appropriate)<br>Filing Date |
|                      | HN                     | 5,602,524          | 2/11/97 | Mock et al.<br>(corres. to JP 3212311) | —                  | —                               |
|                      | HN                     | 6,112,585          | 9/5/00  | Schrottle et al.                       | —                  | —                               |
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| FOREIGN PATENT DOCUMENTS |                        |   |         |                          |                    | Translation |    |
|--------------------------|------------------------|---|---------|--------------------------|--------------------|-------------|----|
| Ref.<br>Desig.           | Examiner's<br>Initials | Document<br>Number                            | Date    | Country                  | Class/<br>Subclass | Yes         | No |
|                          | HN                     | 2001-80321                                    | 3/27/01 | Japan<br>Takamura et al. | —                  | X           |    |
|                          | HN                     | 3212311<br>(Discussed in page 1 of the Spec.) | 7/19/01 | Japan<br>Mock et al.     | —                  |             |    |
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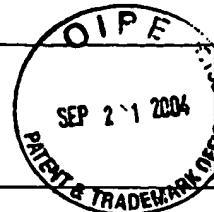
| OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.) |                        |  |
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| Ref.<br>Desig.   | Examiner's<br>Initials |  |
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EXAMINER: Hung Nguyen Date Considered: 10/15/04

EXAMINER: Please initial if citation considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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| ATTY. DKT NO. | 11-173                 | SER. NO. | 10/626,721 |
| APPLICANT     | TSUJI et al.           |          |            |
| FILING DATE   | July 25, 2003          |          |            |
|               | GROUP <u>2632 2636</u> |          |            |

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

| EXAMINER INITIAL |  | DOCUMENT NUMBER | DATE | NAME | CLASS | SUB CLASS |
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|    |  | DOCUMENT NUMBER  | DATE     | COUNTRY | NAME | CLASS | SUB CLASS | YES | TRANSLATION |                  |
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|    |  |                  |          |         |      |       |           |     | NO          | English Abstract |
| HN |  | JP-A-2001-322411 | 11/20/01 | JAPAN   | —    | —     | —         |     |             | X                |
| HN |  | JP-A-2004-009923 | 1/15/04  | JAPAN   | —    | —     | —         |     |             | X                |
|    |  |                  |          |         |      |       |           |     |             |                  |
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\* Full English text of the JP Document will be available in machine-translated form from JP (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

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| EXAMINER | <i>Hungzunger</i> | DATE CONSIDERED<br><i>10/15/04</i> |

Rev. 10/94 (Form 3.05)